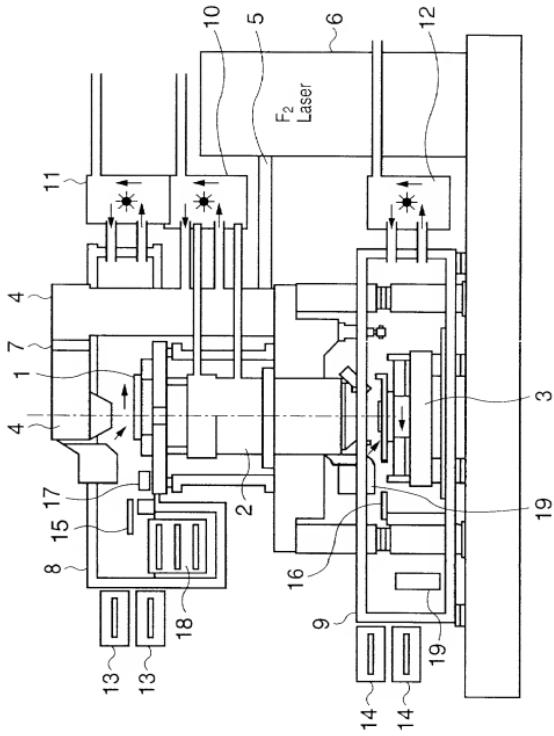


FIG. 1



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FIG. 2

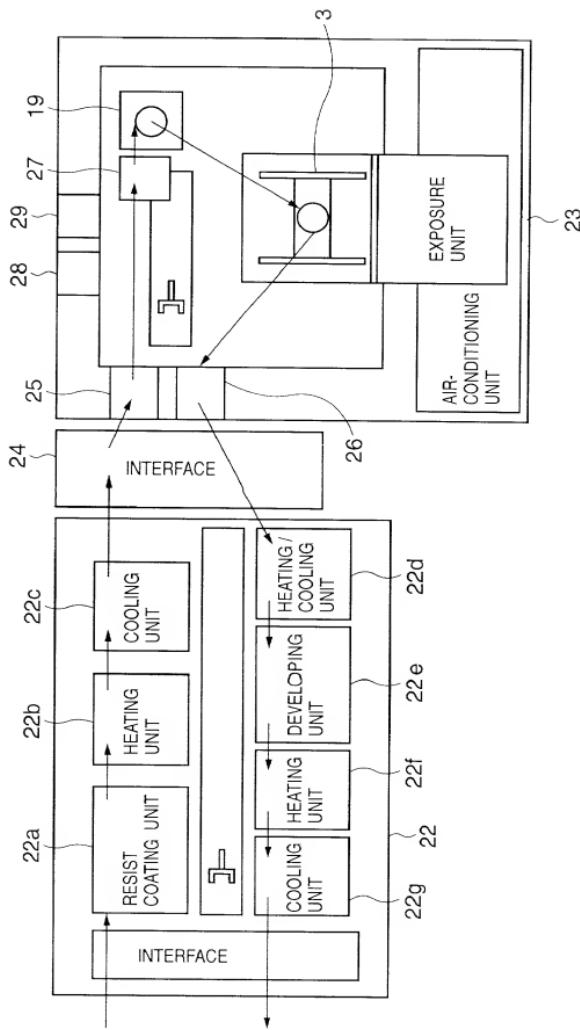


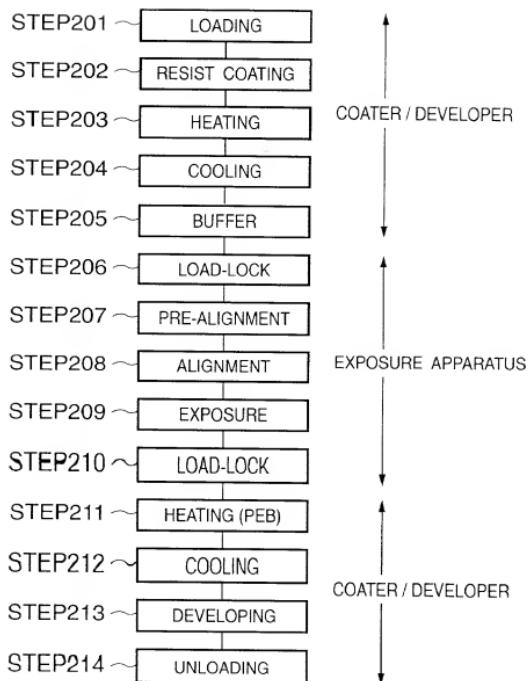
FIG. 3

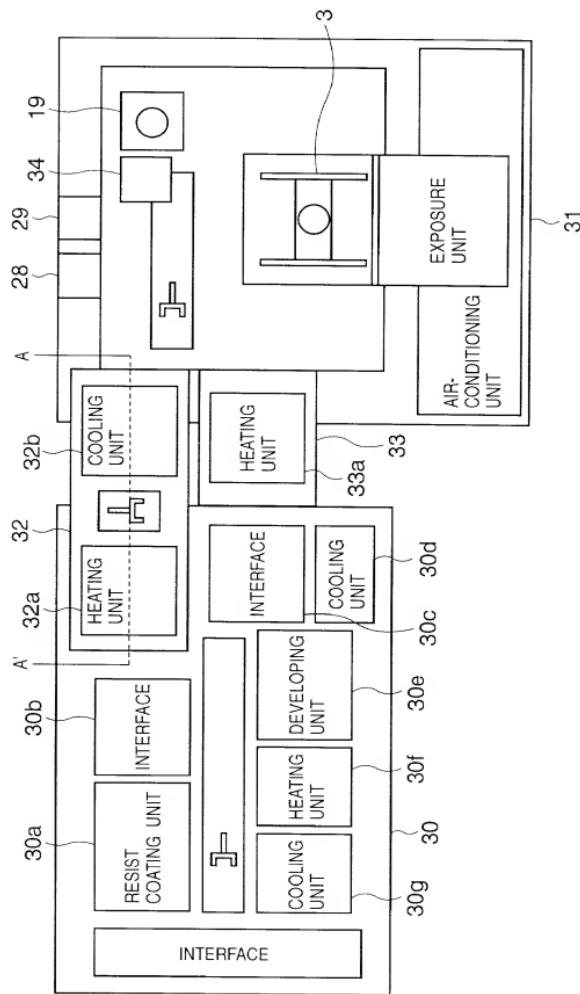
FIG. 4

FIG. 5

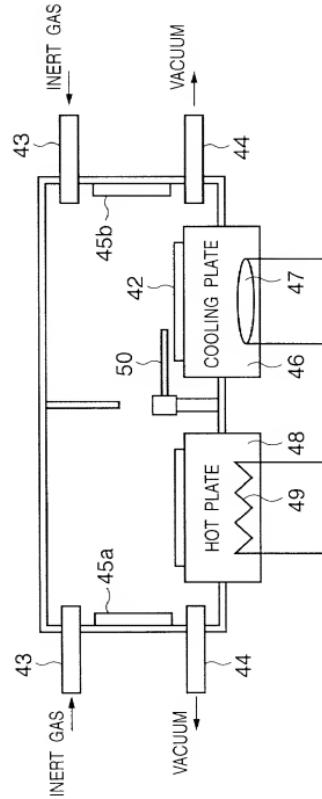


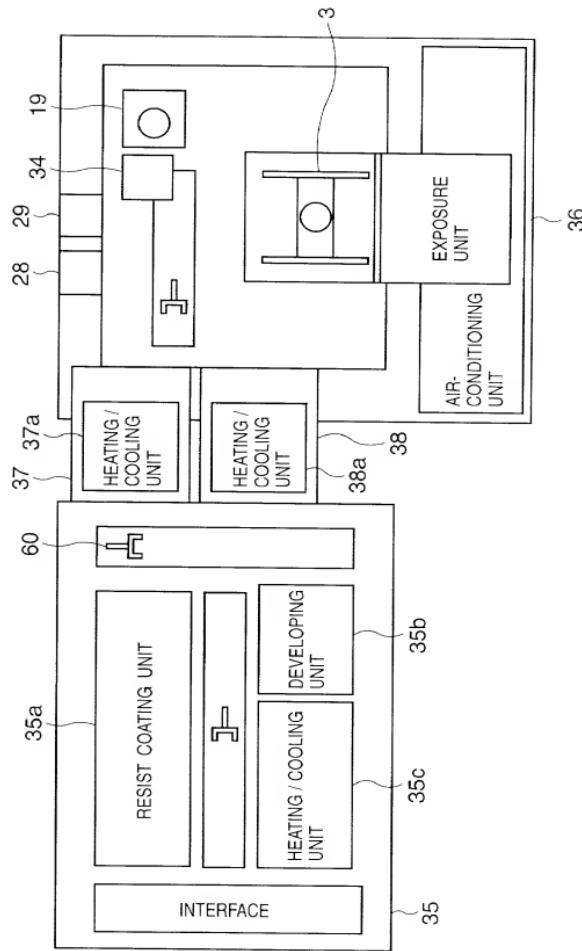
FIG. 6

FIG. 7

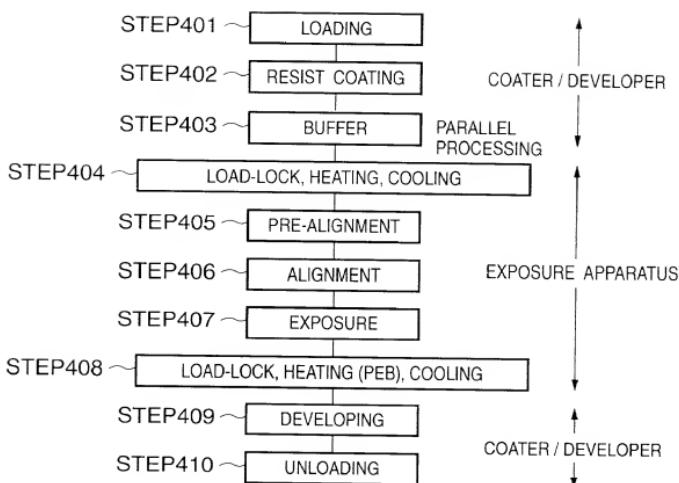


FIG. 8

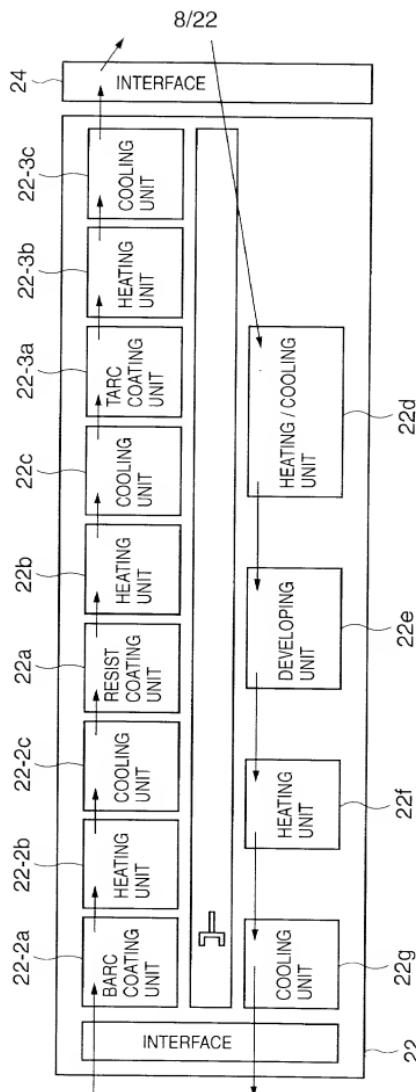
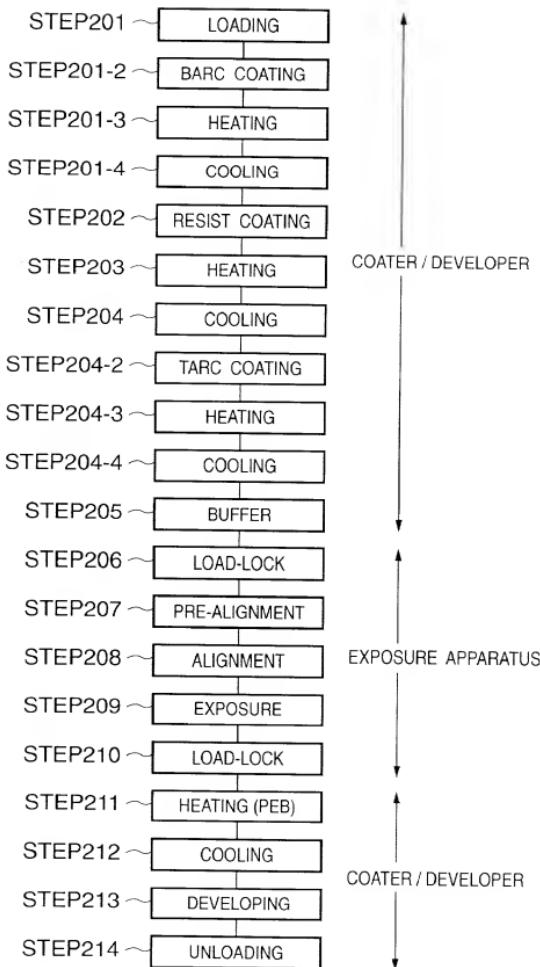


FIG. 9



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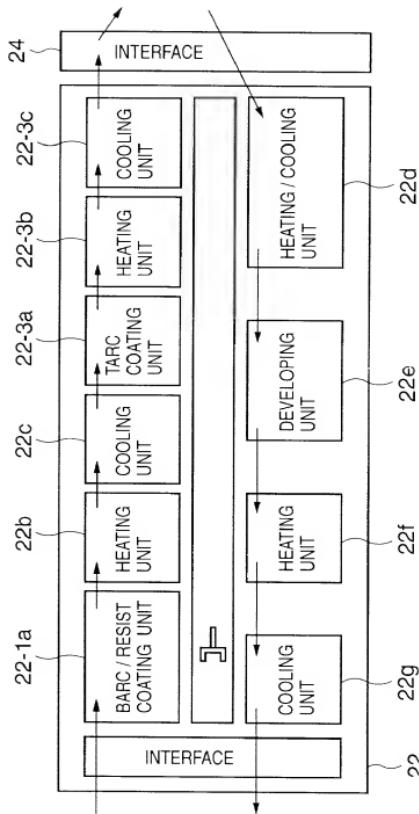
FIG. 10

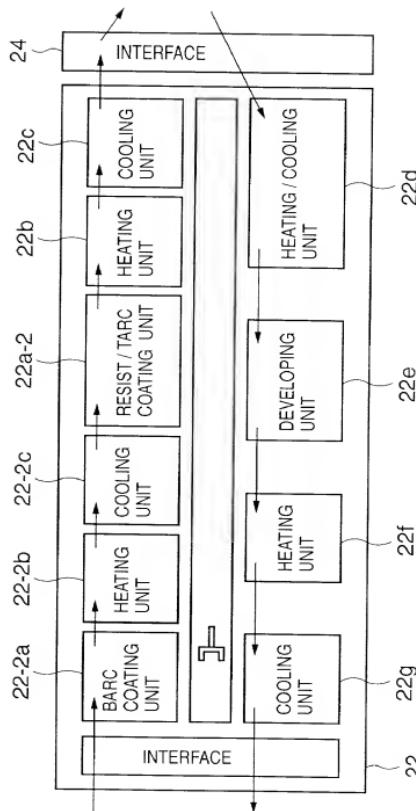
FIG. 11

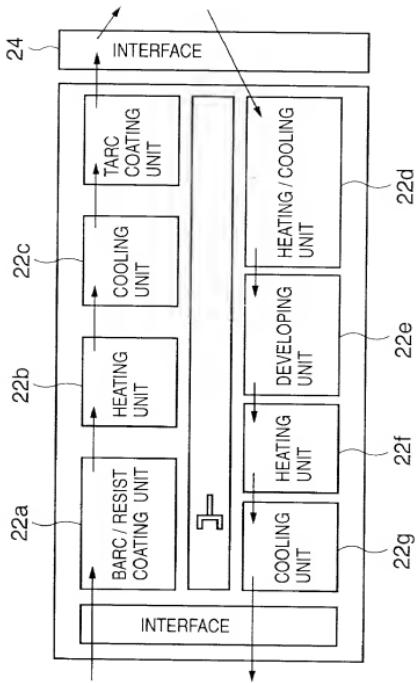
FIG. 12

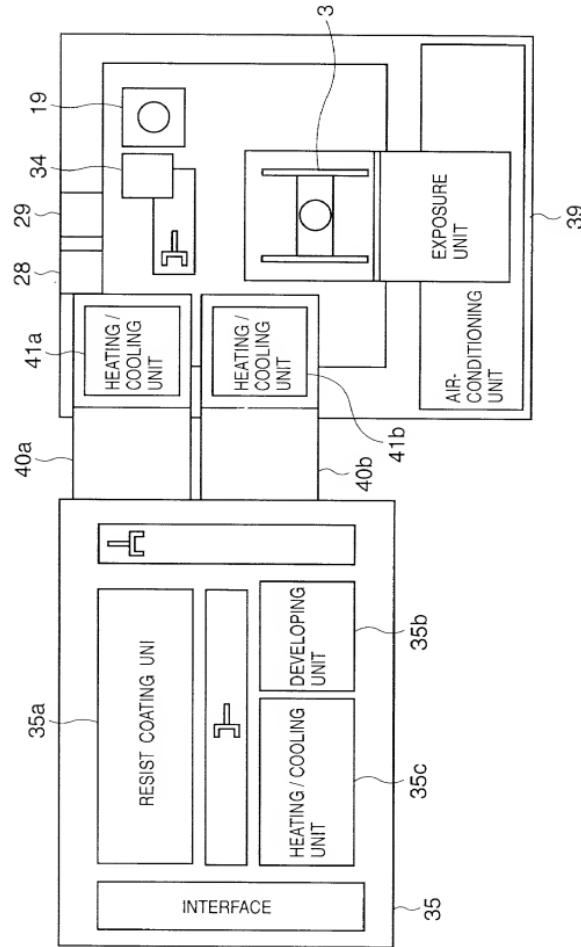
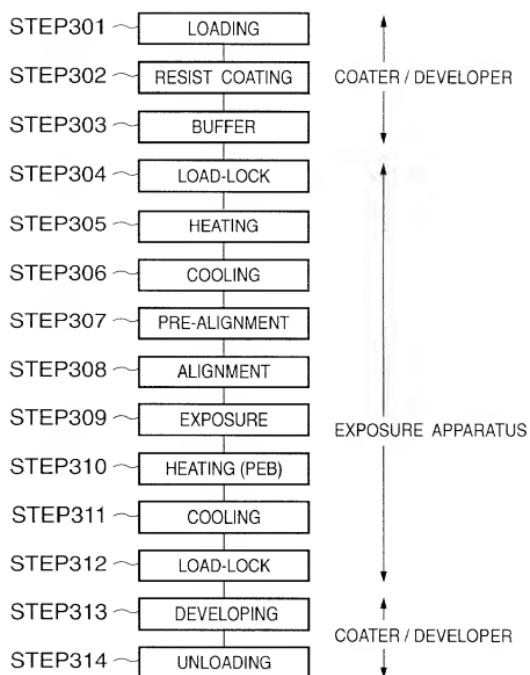
FIG. 13

FIG. 14



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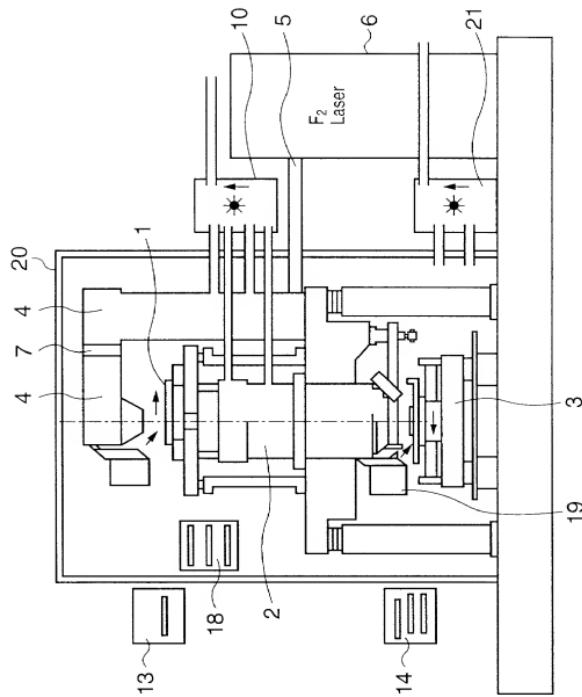
FIG. 15

FIG. 16

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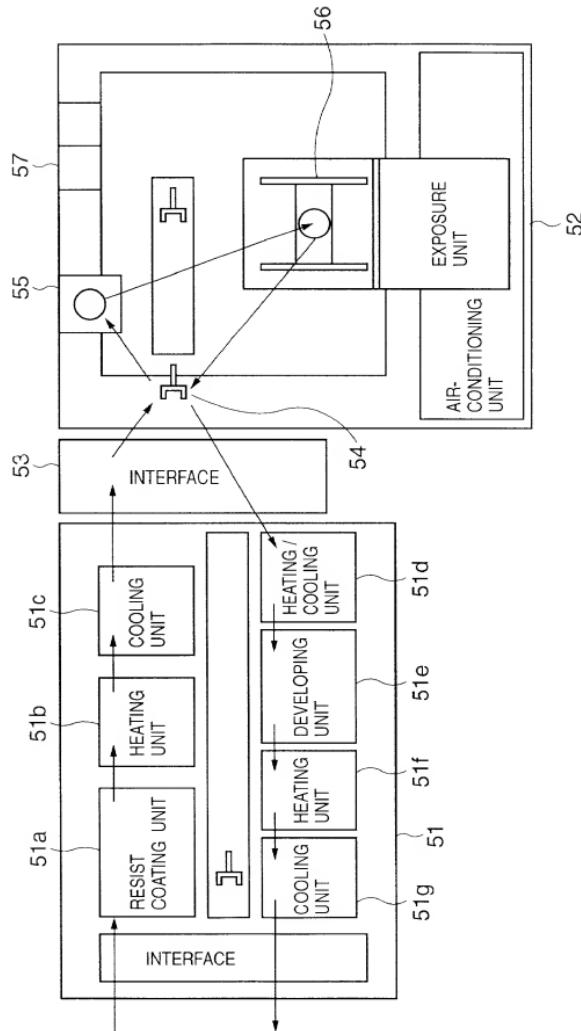
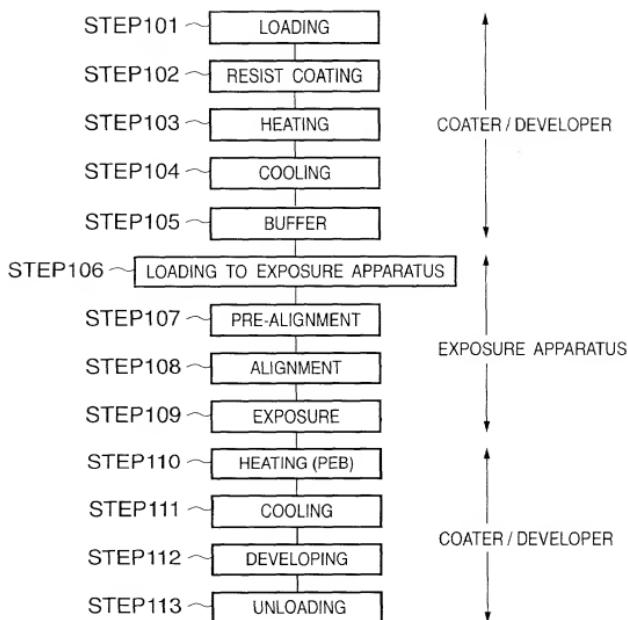


FIG. 17



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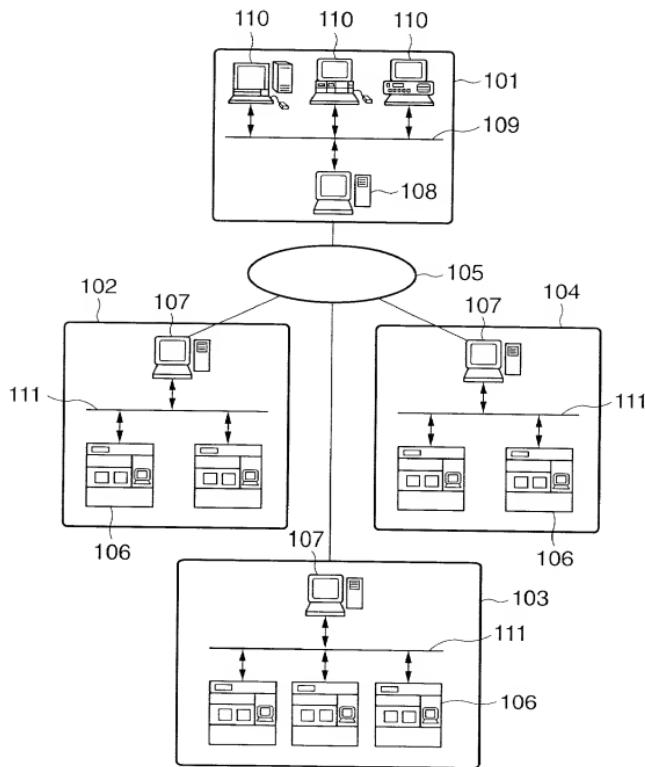
FIG. 18

FIG. 19

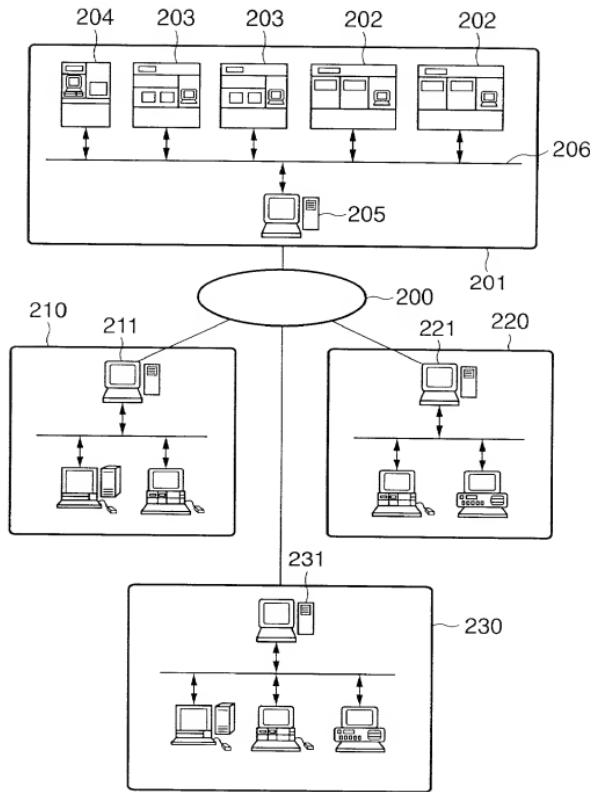


FIG. 20

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URL

TROUBLE DB INPUT WINDOW

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TYPE OF APPARATUS 401

SUBJECT 403

SERIAL NUMBER S/N 402

DEGREE OF URGENCY 405

SYMPTOM 406

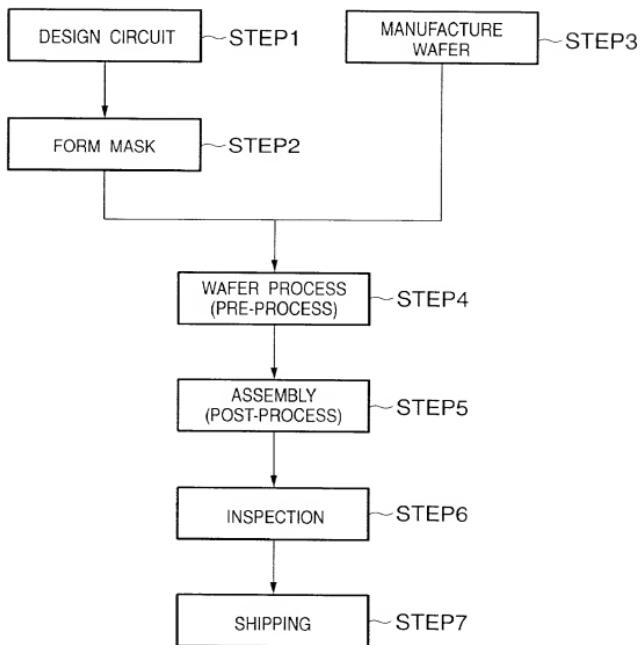
REMEDY 407

PROGRESS 408

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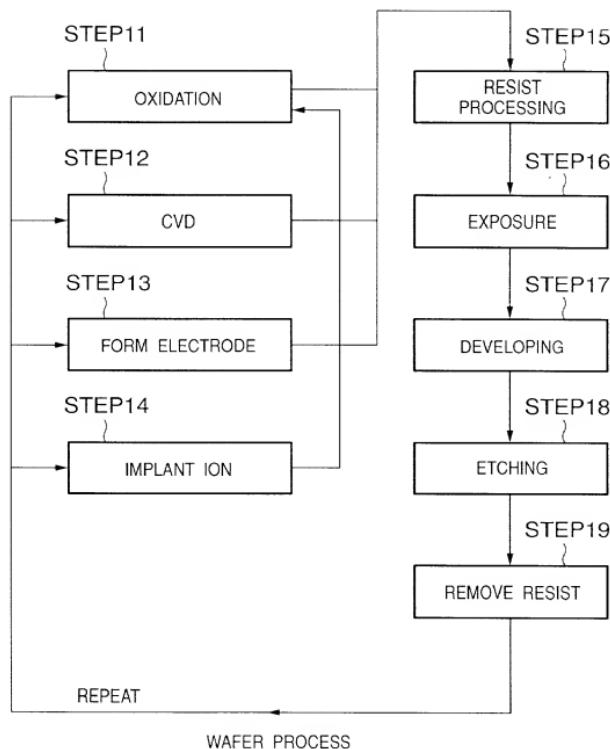
[LINK TO RESULT LIST DATABASE](#) [SOFTWARE LIBRARY](#) [OPERATION GUIDE](#)

FIG. 21



SEMICONDUCTOR DEVICE MANUFACTURING FLOW

FIG. 22



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